

Wavelet-Based Analysis and Synthesis of Long Memory Processes

- DWT well-suited for long memory processes (LMPs)
- basic idea: DWT approximately decorrelates LMPs
- on synthesis side, leads to DWT-based simulation of LMPs
- on analysis side, leads to wavelet-based maximum likelihood and least squares estimators for LMP parameters, along with a test for homogeneity of variance

Wavelets and Long Memory Processes: I

- wavelet filters are approximate band-pass filters, with nominal pass-bands $[1/2^{j+1}, 1/2^j]$ (called j th ‘octave band’)
- suppose $\{X_t\}$ has $S_X(\cdot)$ as its spectral density function (SDF)
- statistical properties of $\{W_{j,t}\}$ are simple if $S_X(\cdot)$ has simple structure within j th octave band
- example: fractionally differenced (FD) process

$$(1 - B)^\delta X_t = \varepsilon_t,$$

(where B is the backward shift operator such that $(1 - B)X_t = X_t - X_{t-1}$) having SDF

$$S_X(f) = \sigma_\varepsilon^2 / [4 \sin^2(\pi f)]^\delta$$

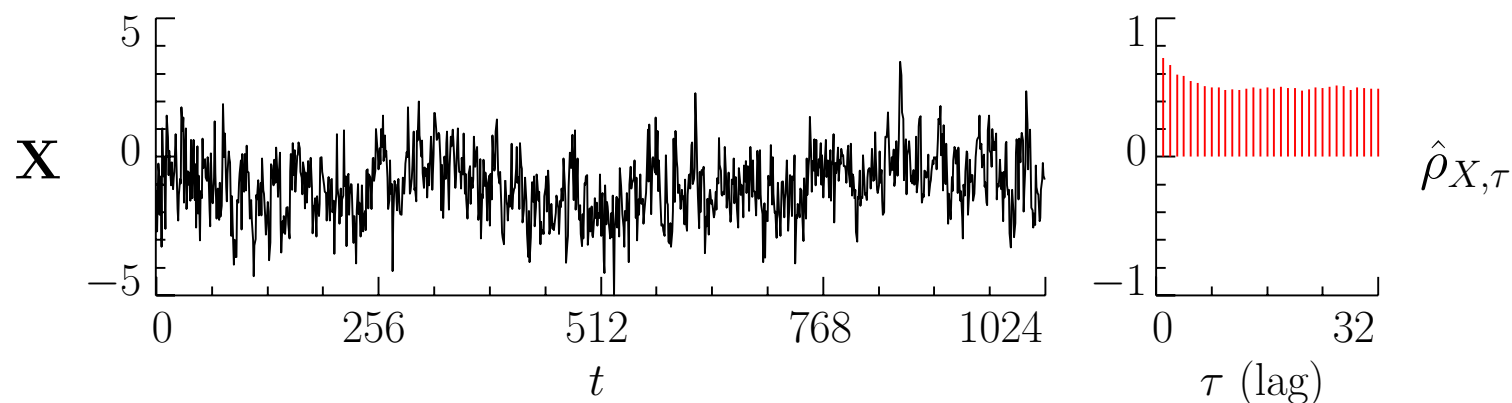
Wavelets and Long Memory Processes: II

- FD process controlled by two parameters: δ and σ_ε^2
- for small f , have $S_X(f) \approx C|f|^{-2\delta}$; i.e., a power law
- $\log(S_X(f))$ vs. $\log(f)$ is approximately linear with slope -2δ
- for large τ_j , the wavelet variance at scale τ_j , namely $\nu_X^2(\tau_j)$, satisfies $\nu_X^2(\tau_j) \approx C'\tau_j^{2\delta-1}$
- $\log(\nu_X^2(\tau_j))$ vs. $\log(\tau_j)$ is approximately linear, slope $2\delta - 1$
- approximately ‘self-similar’ (or ‘fractal’)
- stationary ‘long memory’ process (LMP) if $0 < \delta < 1/2$: correlation between X_t and $X_{t+\tau}$ dies down slowly as τ increases

Wavelets and Long Memory Processes: III

- power law model ubiquitous in physical sciences
 - voltage fluctuations across cell membranes
 - density fluctuations in hour glass
 - traffic fluctuations on Japanese expressway
 - impedance fluctuations in geophysical borehole
 - fluctuations in the rotation of the earth
 - X-ray time variability of galaxies
- DWT well-suited to study FD process and other LMPs
 - ‘self-similar’ filters used on ‘self-similar’ processes
 - key idea: DWT approximately decorrelates LMPs

DWT of a Long Memory Process: I



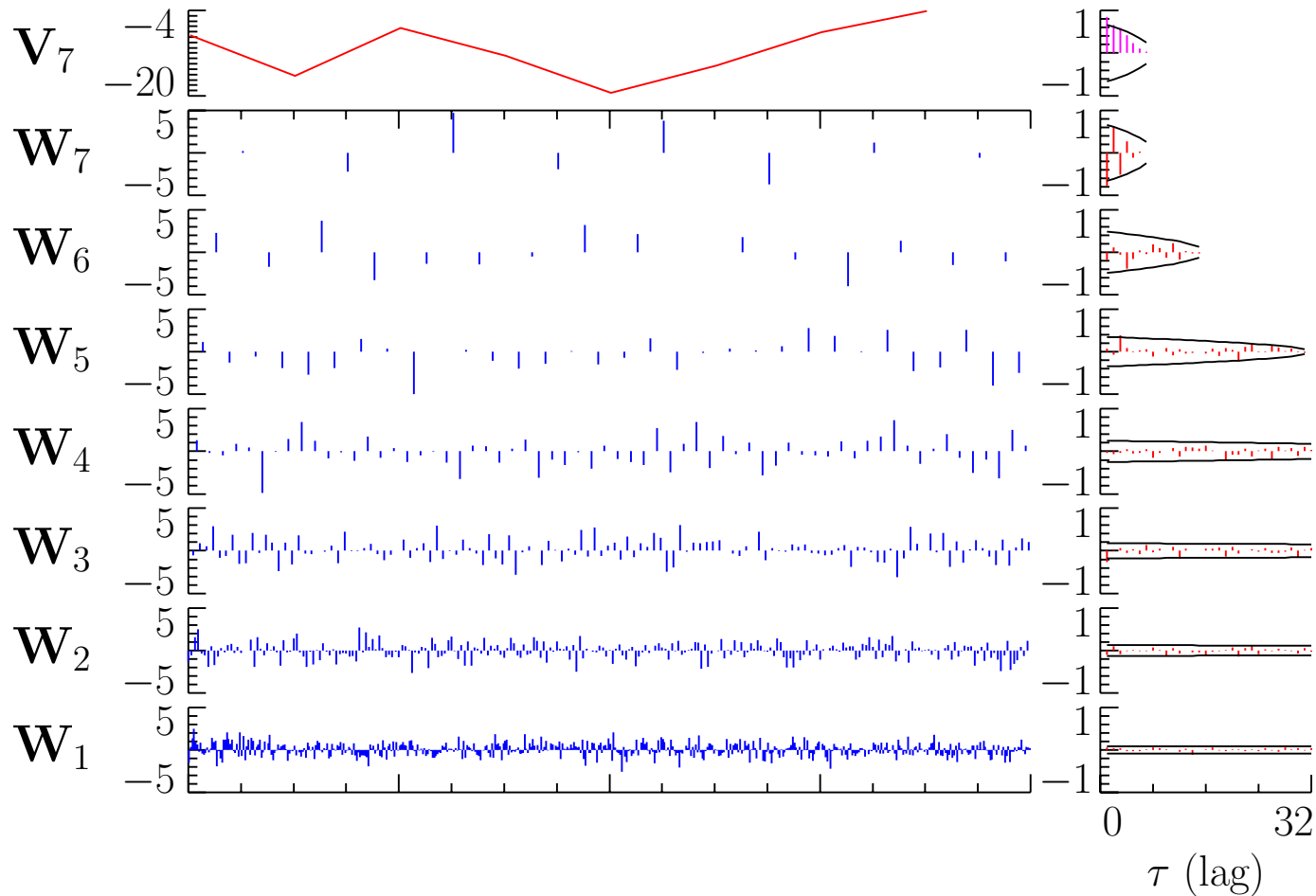
- realization of an FD(0.4) time series \mathbf{X} along with its sample autocorrelation sequence (ACS): for $\tau \geq 0$,

$$\hat{\rho}_{X,\tau} \equiv \frac{\frac{1}{N} \sum_{t=0}^{N-1-\tau} X_t X_{t+\tau}}{\frac{1}{N} \sum_{t=0}^{N-1} X_t^2} = \frac{\sum_{t=0}^{N-1-\tau} X_t X_{t+\tau}}{\sum_{t=0}^{N-1} X_t^2},$$

which assumes that FD(0.4) is known to have zero mean

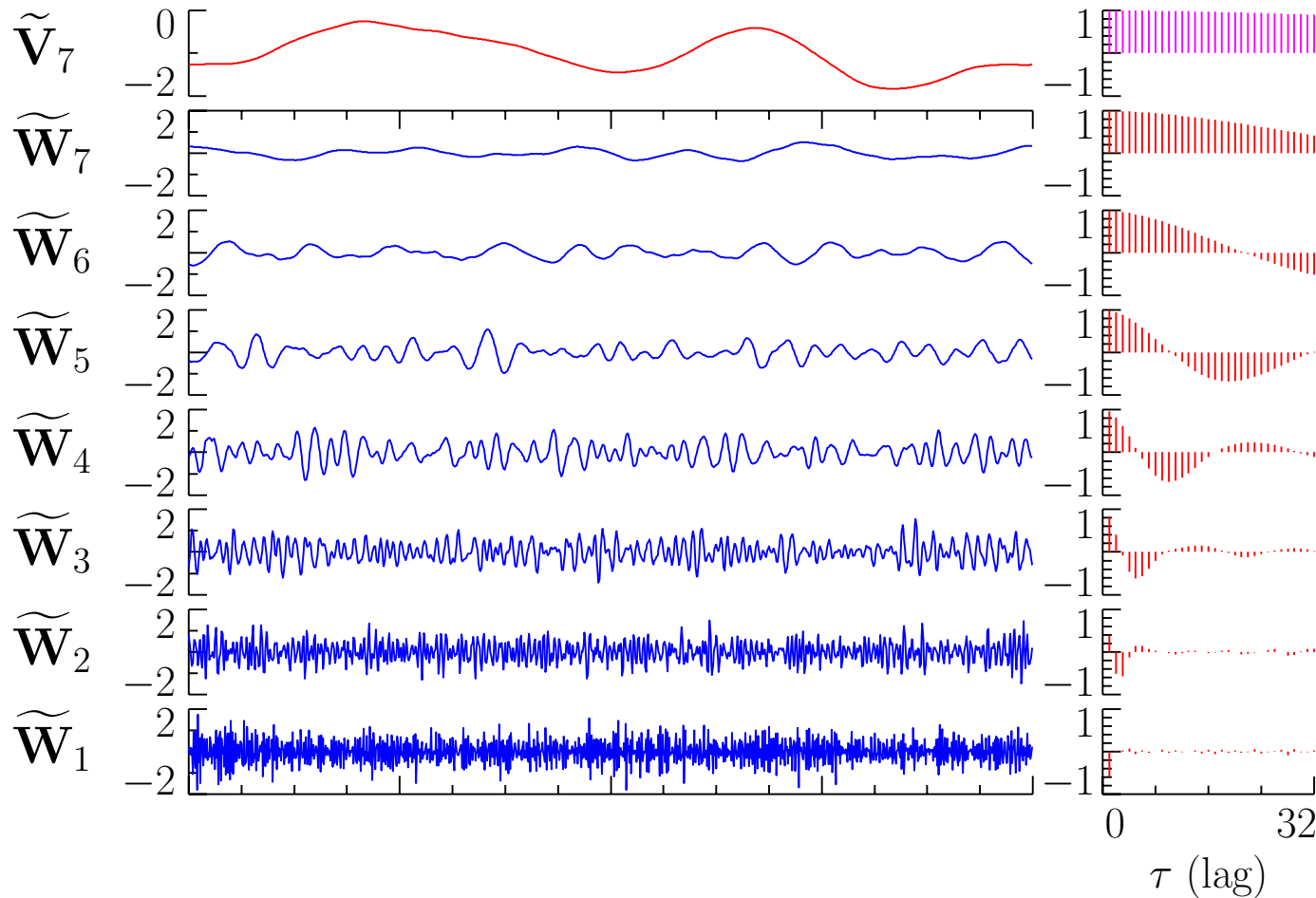
- note that ACS dies down slowly (typical for LMPs)

DWT of a Long Memory Process: II



- LA(8) DWT of FD(0.4) series and sample ACSs for each \mathbf{W}_j & \mathbf{V}_7 , along with 95% confidence intervals for white noise

MODWT of a Long Memory Process



- LA(8) MODWT of FD(0.4) series & sample ACSs for MODWT coefficients, none of which are approximately uncorrelated

DWT of a Long Memory Process: III

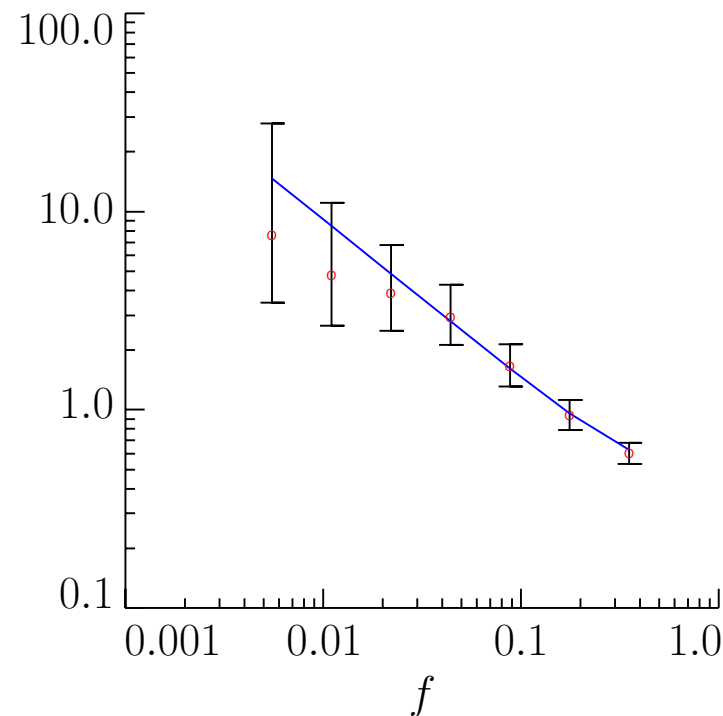
- in contrast to \mathbf{X} , ACSs for \mathbf{W}_j consistent with white noise
- variance of \mathbf{W}_j increases with j – to see why, note that

$$\begin{aligned}\text{var} \{W_{j,t}\} &= \int_{-1/2}^{1/2} \mathcal{H}_j(f) S_X(f) df \\ &\approx 2 \int_{1/2^{j+1}}^{1/2^j} 2^j S_X(f) df \\ &= \frac{1}{\frac{1}{2^j} - \frac{1}{2^{j+1}}} \int_{1/2^{j+1}}^{1/2^j} S_X(f) df \equiv C_j,\end{aligned}$$

where C_j is average value of $S_X(\cdot)$ over $[1/2^{j+1}, 1/2^j]$

- for FD process, can argue that $C_j \approx S_X(1/2^{j+\frac{1}{2}})$, where $1/2^{j+\frac{1}{2}}$ is midpoint of interval $[1/2^{j+1}, 1/2^j]$

DWT of a Long Memory Process: IV



- plot shows $\widehat{\text{var}}\{W_{j,t}\}$ (circles) & $S_X(1/2^{j+1/2})$ (curve) versus $1/2^{j+1/2}$, along with 95% confidence intervals for $\text{var}\{W_{j,t}\}$
- observed $\widehat{\text{var}}\{W_{j,t}\}$ agrees well with theoretical $\text{var}\{W_{j,t}\}$

Correlations Within a Scale and Between Two Scales

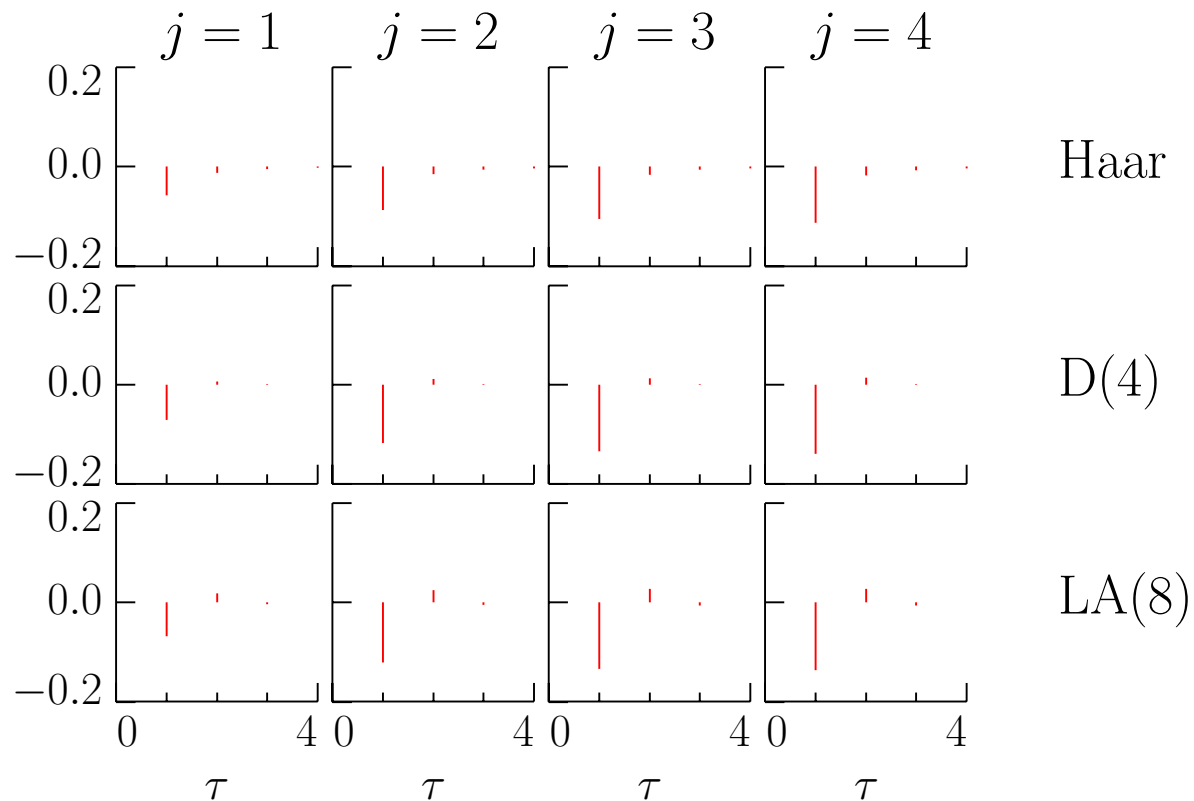
- let $\{s_{X,\tau}\}$ denote autocovariance sequence (ACVS) for $\{X_t\}$; i.e., $s_{X,\tau} = \text{cov}\{X_t, X_{t+\tau}\}$
- let $\{h_{j,l}\}$ denote equivalent wavelet filter for j th level
- to quantify decorrelation, can write

$$\text{cov}\{W_{j,t}, W_{j',t'}\} = \sum_{l=0}^{L_j-1} \sum_{l'=0}^{L_{j'}-1} h_{j,l} h_{j',l'} s_{X, 2^j(t+1)-l-2^{j'}(t'+1)+l'},$$

from which we can get ACVS (and hence within-scale correlations) for $\{W_{j,t}\}$:

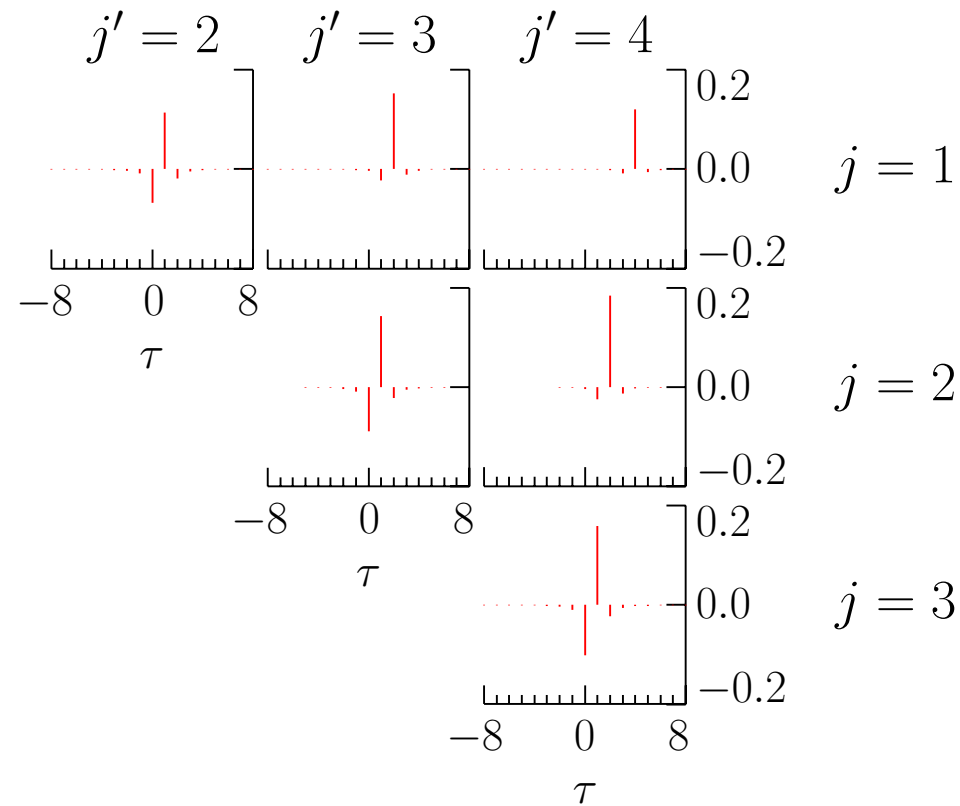
$$\text{cov}\{W_{j,t}, W_{j,t+\tau}\} = \sum_{m=-(L_j-1)}^{L_j-1} s_{X, 2^j\tau+m} \sum_{l=0}^{L_j-|m|-1} h_{j,l} h_{j,l+|m|}$$

Correlations Within a Scale



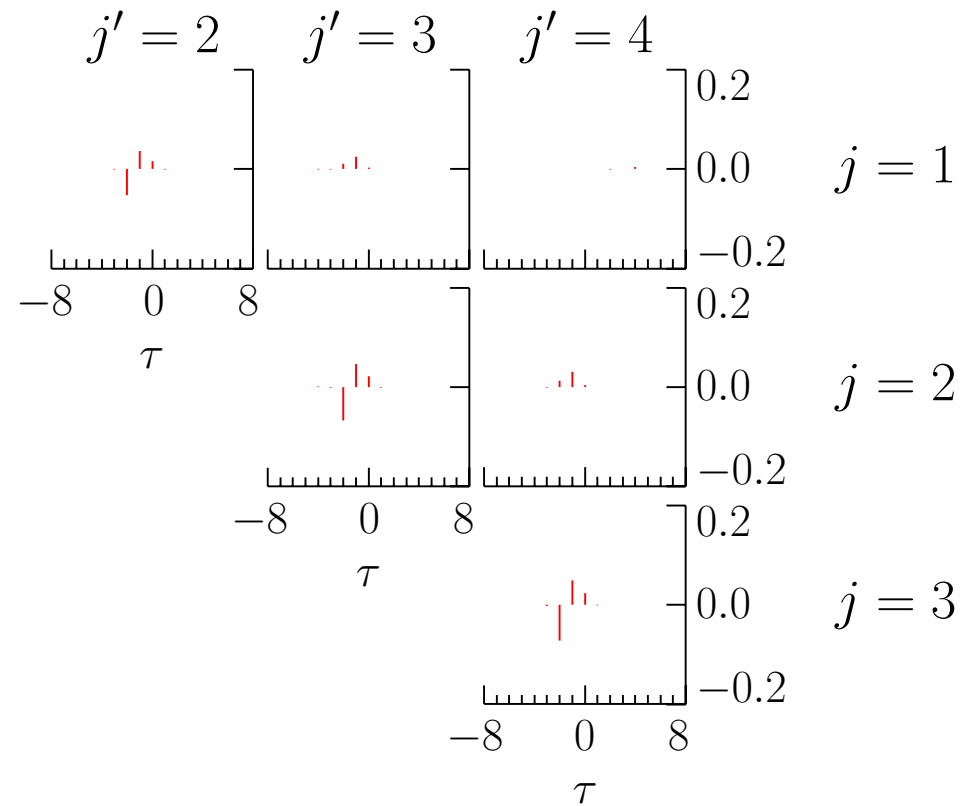
- correlations between $W_{j,t}$ and $W_{j,t+\tau}$ for an FD(0.4) process
- correlations within scale are slightly smaller for Haar
- maximum magnitude of correlation is less than 0.2

Correlations Between Two Scales: I



- correlation between Haar wavelet coefficients $W_{j,t}$ and $W_{j',t'}$ from FD(0.4) process and for levels satisfying $1 \leq j < j' \leq 4$

Correlations Between Two Scales: II



- same as before, but now for LA(8) wavelet coefficients
- correlations between scales decrease as L increases

Wavelet Domain Description of FD Process

- DWT acts as a decorrelating transform for FD process (also true for fractional Gaussian noise, pure power law etc.)
- wavelet domain description is simple
- wavelet coefficients within a given scale are approximately uncorrelated (refinement: assume 1st order autoregressive model)
- wavelet coefficients have a scale-dependent variance, but these variances are controlled by the two FD parameters (δ and σ_ε^2)
- wavelet coefficients between scales are also approximately uncorrelated (approximation improves as filter width L increases)

DWT-Based Simulation

- properties of DWT of FD processes lead to schemes for simulating time series $\mathbf{X} \equiv [X_0, \dots, X_{N-1}]^T$ with zero mean and with a multivariate Gaussian distribution
- with $N = 2^J$, recall that $\mathbf{X} = \mathcal{W}^T \mathbf{W}$, where

$$\mathbf{W} = \begin{bmatrix} \mathbf{W}_1 \\ \mathbf{W}_2 \\ \vdots \\ \mathbf{W}_j \\ \vdots \\ \mathbf{W}_J \\ \mathbf{V}_J \end{bmatrix}$$

Basic DWT-Based Simulation Scheme

- assume \mathbf{W} to contain N uncorrelated Gaussian (normal) random variables (RVs) with zero mean
- assume \mathbf{W}_j to have variance $C_j \approx S_X(1/2^{j+\frac{1}{2}})$
- assume single RV in \mathbf{V}_J to have variance C_{J+1} (see textbook for details about how to set C_{J+1})
- approximate FD time series \mathbf{X} via $\mathbf{Y} \equiv \mathcal{W}^T \Lambda^{1/2} \mathbf{Z}$, where
 - $\Lambda^{1/2}$ is $N \times N$ diagonal matrix with diagonal elements

$$\underbrace{C_1^{1/2}, \dots, C_1^{1/2}}_{\frac{N}{2} \text{ of these}}, \underbrace{C_2^{1/2}, \dots, C_2^{1/2}}_{\frac{N}{4} \text{ of these}}, \dots, \underbrace{C_{J-1}^{1/2}, C_{J-1}^{1/2}}_{2 \text{ of these}}, C_J^{1/2}, C_{J+1}^{1/2}$$
 - \mathbf{Z} is vector of deviations drawn from a Gaussian distribution with zero mean and unit variance

Refinements to Basic Scheme: I

- covariance matrix for approximation \mathbf{Y} does not correspond to that of a stationary process
- recall \mathcal{W} treats \mathbf{X} as if it were circular
- let \mathcal{T} be $N \times N$ ‘circular shift’ matrix:

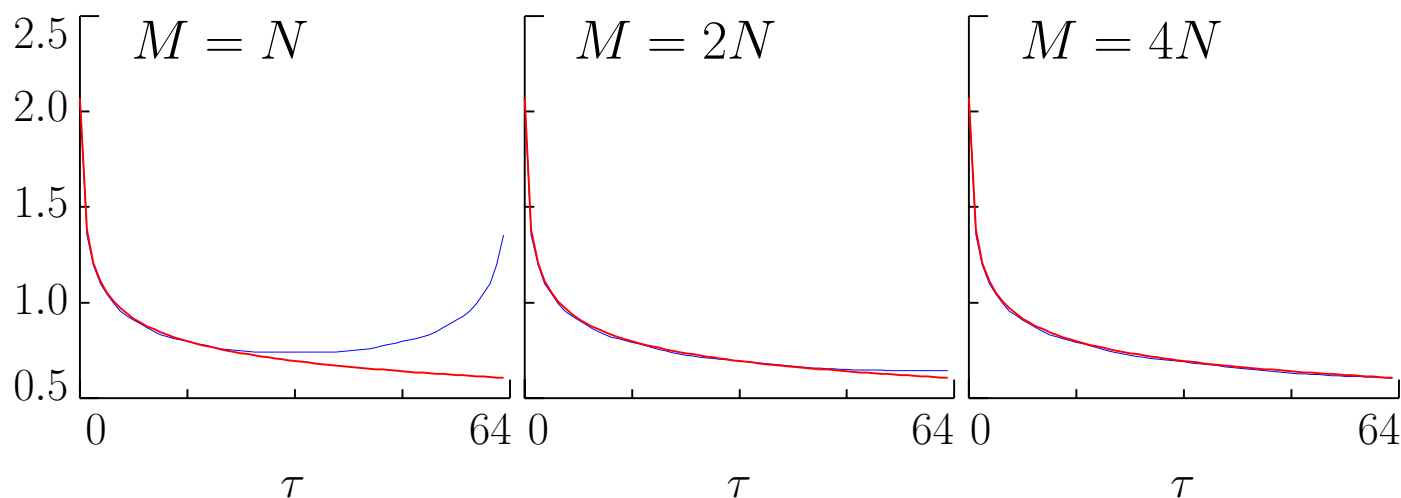
$$\mathcal{T} \begin{bmatrix} Y_0 \\ Y_1 \\ Y_2 \\ Y_3 \end{bmatrix} = \begin{bmatrix} Y_1 \\ Y_2 \\ Y_3 \\ Y_0 \end{bmatrix} ; \quad \mathcal{T}^2 \begin{bmatrix} Y_0 \\ Y_1 \\ Y_2 \\ Y_3 \end{bmatrix} = \begin{bmatrix} Y_2 \\ Y_3 \\ Y_0 \\ Y_1 \end{bmatrix} ; \quad \text{etc.}$$

- let κ be uniformly distributed over $0, \dots, N-1$
- define $\tilde{\mathbf{Y}} \equiv \mathcal{T}^\kappa \mathbf{Y}$
- $\tilde{\mathbf{Y}}$ is stationary with ACVS given by, say, $s_{\tilde{Y}, \tau}$

Refinements to Basic Scheme: II

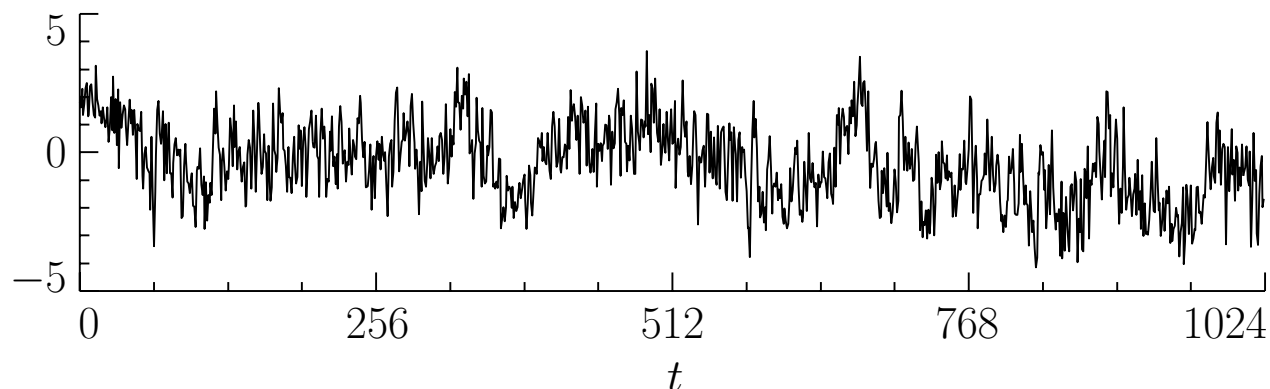
- Q: how well does $\{s_{\tilde{Y},\tau}\}$ match $\{s_{X,\tau}\}$?
- due to circularity, find that $s_{\tilde{Y},N-\tau} = s_{\tilde{Y},\tau}$ for $\tau = 1, \dots, N/2$
- implies $s_{\tilde{Y},\tau}$ cannot approximate $s_{X,\tau}$ well for τ close to N
- can patch up by simulating $\tilde{\mathbf{Y}}$ with $M > N$ elements and then extracting first N deviates ($M = 4N$ works well)

Refinements to Basic Scheme: III



- plot shows **true** ACVS $\{s_{X,\tau}\}$ (**thick** curves) for FD(0.4) process and wavelet-based **approximate** ACVSs $\{s_{\tilde{Y},\tau}\}$ (**thin** curves) based on an LA(8) DWT in which an $N = 64$ series is extracted from $M = N$, $M = 2N$ and $M = 4N$ series

Example and Some Notes



- simulated FD(0.4) series (LA(8), $N = 1024$ and $M = 4N$)
- notes:
 - can form realizations faster than best exact method
 - efficient ‘real-time’ simulation of extremely long time series (e.g, $N = 2^{30} = 1,073,741,824$ or even longer)
 - effect of random circular shifting is to render time series non-Gaussian (a Gaussian mixture model)

MLEs of FD Parameters: I

- FD process depends on 2 parameters, namely, δ and σ_ε^2 :

$$S_X(f) = \frac{\sigma_\varepsilon^2}{[4 \sin^2(\pi f)]^\delta}$$

- given $\mathbf{X} = [X_0, X_1, \dots, X_{N-1}]^T$ with $N = 2^J$, suppose we want to estimate δ and σ_ε^2
- if \mathbf{X} is stationary (i.e. $\delta < 1/2$) and multivariate Gaussian, can use the maximum likelihood (ML) method

MLEs of FD Parameters: II

- definition of Gaussian likelihood function:

$$L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X}) \equiv \frac{1}{(2\pi)^{N/2} |\Sigma_{\mathbf{X}}|^{1/2}} e^{-\mathbf{X}^T \Sigma_{\mathbf{X}}^{-1} \mathbf{X} / 2}$$

where $\Sigma_{\mathbf{X}}$ is covariance matrix for \mathbf{X} , with (s, t) th element given by $s_{X, s-t}$, and $|\Sigma_{\mathbf{X}}|$ & $\Sigma_{\mathbf{X}}^{-1}$ denote determinant & inverse

- ML estimators of δ and σ_ε^2 maximize $L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})$ or, equivalently, minimize

$$-2 \log (L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})) = N \log (2\pi) + \log (|\Sigma_{\mathbf{X}}|) + \mathbf{X}^T \Sigma_{\mathbf{X}}^{-1} \mathbf{X}$$

- exact MLEs computationally intensive, mainly because of the need to deal with $|\Sigma_{\mathbf{X}}|$ and $\Sigma_{\mathbf{X}}^{-1}$
- good approximate MLEs of considerable interest

MLEs of FD Parameters: III

- key ideas behind first wavelet-based approximate MLEs
 - have seen that we can approximate FD time series \mathbf{X} by $\mathbf{Y} = \mathcal{W}^T \Lambda^{1/2} \mathbf{Z}$, where $\Lambda^{1/2}$ is a diagonal matrix, all of whose diagonal elements are positive
 - since covariance matrix for \mathbf{Z} is I_N , Equation (262c) says covariance matrix for \mathbf{Y} is
$$\mathcal{W}^T \Lambda^{1/2} I_N (\mathcal{W}^T \Lambda^{1/2})^T = \mathcal{W}^T \Lambda^{1/2} \Lambda^{1/2} \mathcal{W} = \mathcal{W}^T \Lambda \mathcal{W} \equiv \tilde{\Sigma}_{\mathbf{X}},$$
where $\Lambda \equiv \Lambda^{1/2} \Lambda^{1/2}$ is also diagonal
 - can consider $\tilde{\Sigma}_{\mathbf{X}}$ to be an approximation to $\Sigma_{\mathbf{X}}$
- leads to approximation of log likelihood:
$$-2 \log (L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})) \approx N \log (2\pi) + \log (|\tilde{\Sigma}_{\mathbf{X}}|) + \mathbf{X}^T \tilde{\Sigma}_{\mathbf{X}}^{-1} \mathbf{X}$$

MLEs of FD Parameters: IV

- Q: so how does this help us?

- easy to invert $\tilde{\Sigma}_{\mathbf{X}}$:

$$\tilde{\Sigma}_{\mathbf{X}}^{-1} = \left(\mathcal{W}^T \Lambda \mathcal{W} \right)^{-1} = (\mathcal{W})^{-1} \Lambda^{-1} \left(\mathcal{W}^T \right)^{-1} = \mathcal{W}^T \Lambda^{-1} \mathcal{W},$$

where Λ^{-1} is another diagonal matrix, leading to

$$\mathbf{X}^T \tilde{\Sigma}_{\mathbf{X}}^{-1} \mathbf{X} = \mathbf{X}^T \mathcal{W}^T \Lambda^{-1} \mathcal{W} \mathbf{X} = \mathbf{W}^T \Lambda^{-1} \mathbf{W}$$

- easy to compute the determinant of $\tilde{\Sigma}_{\mathbf{X}}$:

$$|\tilde{\Sigma}_{\mathbf{X}}| = |\mathcal{W}^T \Lambda \mathcal{W}| = |\Lambda \mathcal{W} \mathcal{W}^T| = |\Lambda I_N| = |\Lambda|,$$

and the determinant of a diagonal matrix is just the product of its diagonal elements

MLEs of FD Parameters: V

- define the following three functions of δ :

$$C'_j(\delta) \equiv \int_{1/2^{j+1}}^{1/2^j} \frac{2^{j+1}}{[4 \sin^2(\pi f)]^\delta} df \approx \int_{1/2^{j+1}}^{1/2^j} \frac{2^{j+1}}{[2\pi f]^{2\delta}} df$$

$$C'_{J+1}(\delta) \equiv \frac{N\Gamma(1-2\delta)}{\Gamma^2(1-\delta)} - \sum_{j=1}^J \frac{N}{2^j} C'_j(\delta)$$

$$\sigma_\varepsilon^2(\delta) \equiv \frac{1}{N} \left(\frac{V_{J,0}^2}{C'_{J+1}(\delta)} + \sum_{j=1}^J \frac{1}{C'_j(\delta)} \sum_{t=0}^{\frac{N}{2^j}-1} W_{j,t}^2 \right)$$

MLEs of FD Parameters: VI

- wavelet-based approximate MLE $\tilde{\delta}$ for δ is the value that minimizes the following function of δ :

$$\tilde{l}(\delta \mid \mathbf{X}) \equiv N \log(\sigma_{\varepsilon}^2(\delta)) + \log(C'_{J+1}(\delta)) + \sum_{j=1}^J \frac{N}{2^j} \log(C'_j(\delta))$$

- once $\tilde{\delta}$ has been determined, MLE for σ_{ε}^2 is given by $\sigma_{\varepsilon}^2(\tilde{\delta})$
- computer experiments indicate scheme works quite well

Other Wavelet-Based Estimators of FD Parameters

- second MLE approach: formulate likelihood directly in terms of nonboundary wavelet coefficients
 - handles stationary or nonstationary FD processes (i.e., need not assume $\delta < 1/2$)
 - handles certain deterministic trends
- alternative to MLE is least square estimator (LSE)
 - recall that, for large τ and for $\beta = 2\delta - 1$, have
$$\log(\nu_X^2(\tau_j)) \approx \zeta + \beta \log(\tau_j)$$
 - suggests determining δ by regressing $\log(\hat{\nu}_X^2(\tau_j))$ on $\log(\tau_j)$ over range of τ_j
 - weighted LSE takes into account fact that variance of $\log(\hat{\nu}_X^2(\tau_j))$ depends upon scale τ_j (increases as τ_j increases)

Homogeneity of Variance: I

- because DWT decorrelates LMPs, nonboundary coefficients in \mathbf{W}_j should resemble white noise; i.e., $\text{cov}\{W_{j,t}, W_{j,t'}\} \approx 0$ when $t \neq t'$, and $\text{var}\{W_{j,t}\}$ should not depend upon t
- can test for homogeneity of variance in \mathbf{X} using \mathbf{W}_j over a range of levels j
- suppose U_0, \dots, U_{N-1} are independent normal RVs with $E\{U_t\} = 0$ and $\text{var}\{U_t\} = \sigma_t^2$
- want to test null hypothesis

$$H_0 : \sigma_0^2 = \sigma_1^2 = \dots = \sigma_{N-1}^2$$

- can test H_0 versus a variety of alternatives, e.g.,

$$H_1 : \sigma_0^2 = \dots = \sigma_k^2 \neq \sigma_{k+1}^2 = \dots = \sigma_{N-1}^2$$

using normalized cumulative sum of squares

Homogeneity of Variance: II

- to define test statistic D , start with

$$\mathcal{P}_k \equiv \frac{\sum_{j=0}^k U_j^2}{\sum_{j=0}^{N-1} U_j^2}, \quad k = 0, \dots, N-2$$

and then compute $D \equiv \max(D^+, D^-)$, where

$$D^+ \equiv \max_{0 \leq k \leq N-2} \left(\frac{k+1}{N-1} - \mathcal{P}_k \right) \quad \& \quad D^- \equiv \max_{0 \leq k \leq N-2} \left(\mathcal{P}_k - \frac{k}{N-1} \right)$$

- can reject H_0 if observed D is ‘too large,’ where ‘too large’ is quantified by considering distribution of D under H_0
- need to find critical value x_α such that $\mathbf{P}[D \geq x_\alpha] = \alpha$ for, e.g., $\alpha = 0.01, 0.05$ or 0.1

Homogeneity of Variance: III

- once determined, can perform α level test of H_0 :
 - compute D statistic from data U_0, \dots, U_{N-1}
 - reject H_0 at level α if $D \geq x_\alpha$
 - fail to reject H_0 at level α if $D < x_\alpha$
- can determine critical values x_α in two ways
 - Monte Carlo simulations
 - large sample approximation to distribution of D :

$$\mathbf{P}[(N/2)^{1/2}D \geq x] \approx 1 + 2 \sum_{l=1}^{\infty} (-1)^l e^{-2l^2 x^2}$$

(reasonable approximation for $N \geq 128$)

Homogeneity of Variance: IV

- idea: given time series $\{X_t\}$, compute D using nonboundary wavelet coefficients $W_{j,t}$ (there are $M'_j \equiv N_j - L'_j$ of these):

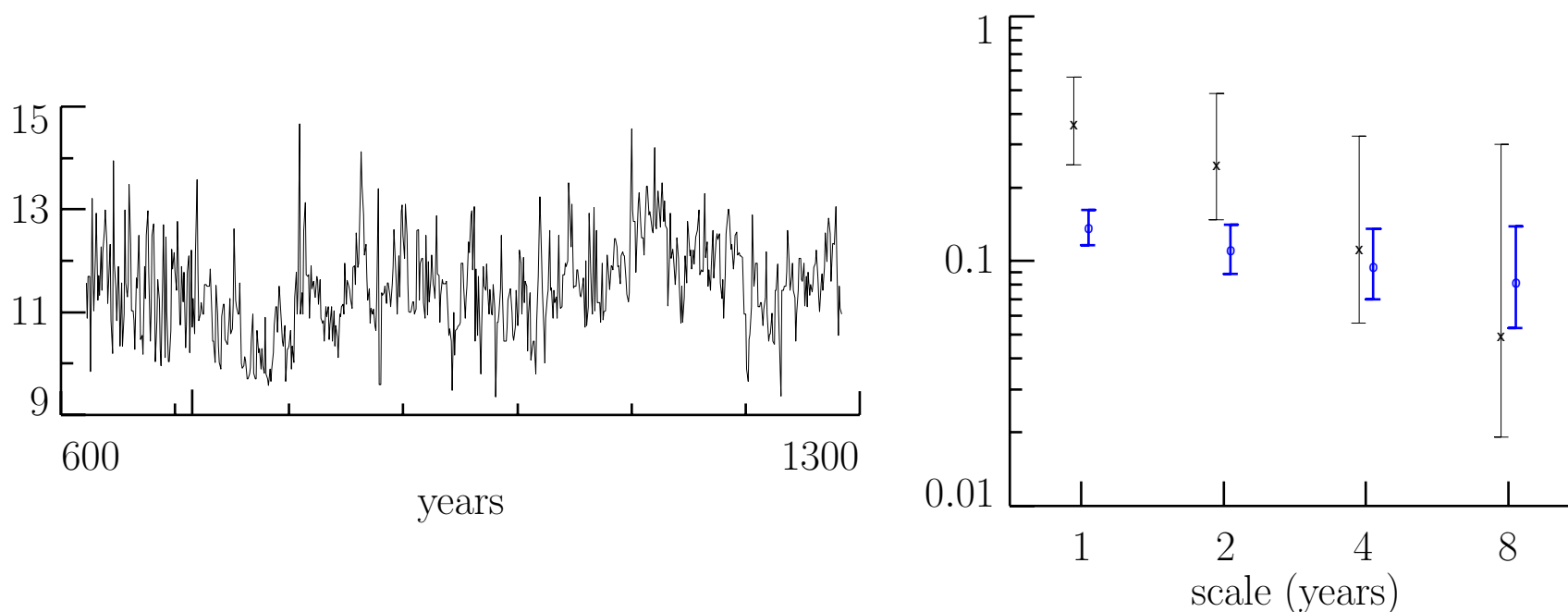
$$\mathcal{P}_k \equiv \frac{\sum_{t=L'_j}^k W_{j,t}^2}{\sum_{t=L'_j}^{N_j-1} W_{j,t}^2}, \quad k = L'_j, \dots, N_j - 2$$

- if null hypothesis rejected at level j , can use nonboundary MODWT coefficients to locate change point based on

$$\tilde{\mathcal{P}}_k \equiv \frac{\sum_{t=L_j-1}^k \tilde{W}_{j,t}^2}{\sum_{t=L_j-1}^{N-1} \tilde{W}_{j,t}^2}, \quad k = L_j - 1, \dots, N - 2$$

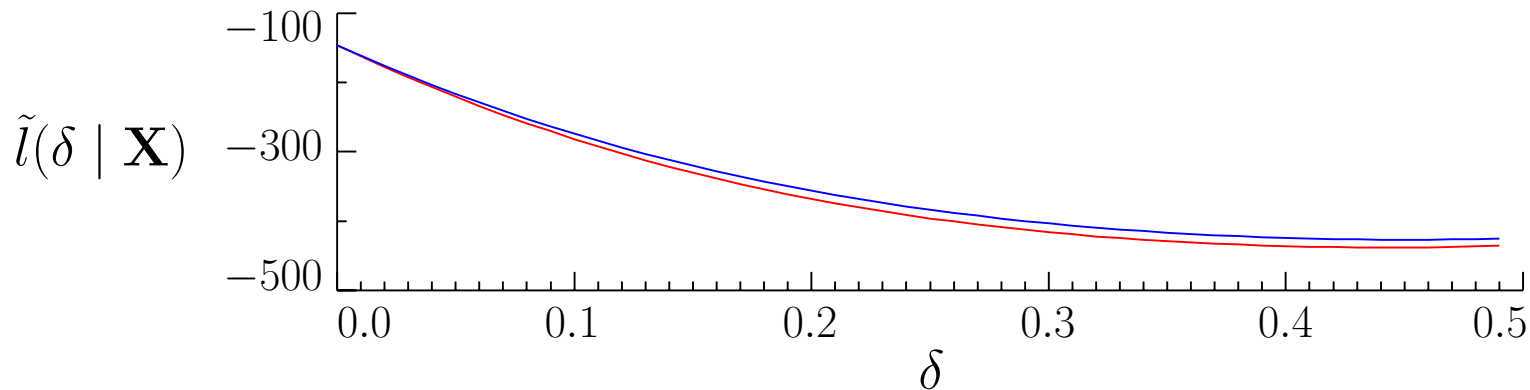
along with analogs \tilde{D}_k^+ and \tilde{D}_k^- of D_k^+ and D_k^-

Annual Minima of Nile River



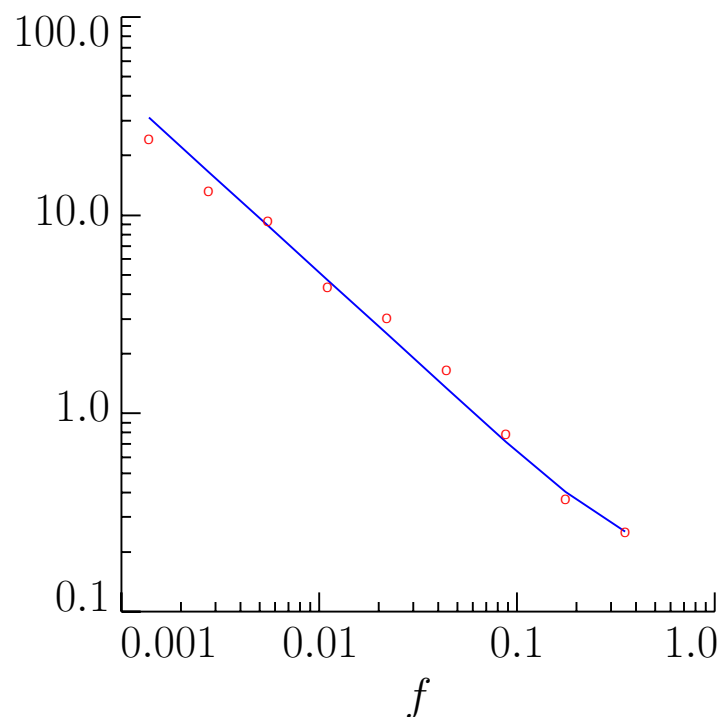
- left-hand plot: annual minima of Nile River
- new measuring device introduced around year 715
- right: Haar $\hat{\nu}_X^2(\tau_j)$ before (x's) and after (o's) year 715.5, with 95% confidence intervals based upon $\chi_{\eta_3}^2$ approximation

Example – Annual Minima of Nile River: II



- based upon last 512 values (years 773 to 1284), plot shows $\tilde{l}(\delta | \mathbf{X})$ versus δ for the first wavelet-based approximate MLE using the LA(8) wavelet (**upper curve**) and corresponding curve for exact MLE (**lower**)
 - wavelet-based approximate MLE is value minimizing **upper curve**: $\tilde{\delta} \doteq 0.4532$
 - exact MLE is value minimizing **lower** curve: $\hat{\delta} \doteq 0.4452$

Example – Annual Minima of Nile River: III



- using last 512 values again, variance of wavelet coefficients computed via LA(8) MLEs $\tilde{\delta}$ and $\sigma_\varepsilon^2(\tilde{\delta})$ (solid curve) as compared to sample variances of LA(8) wavelet coefficients (circles)
- agreement is almost too good to be true!

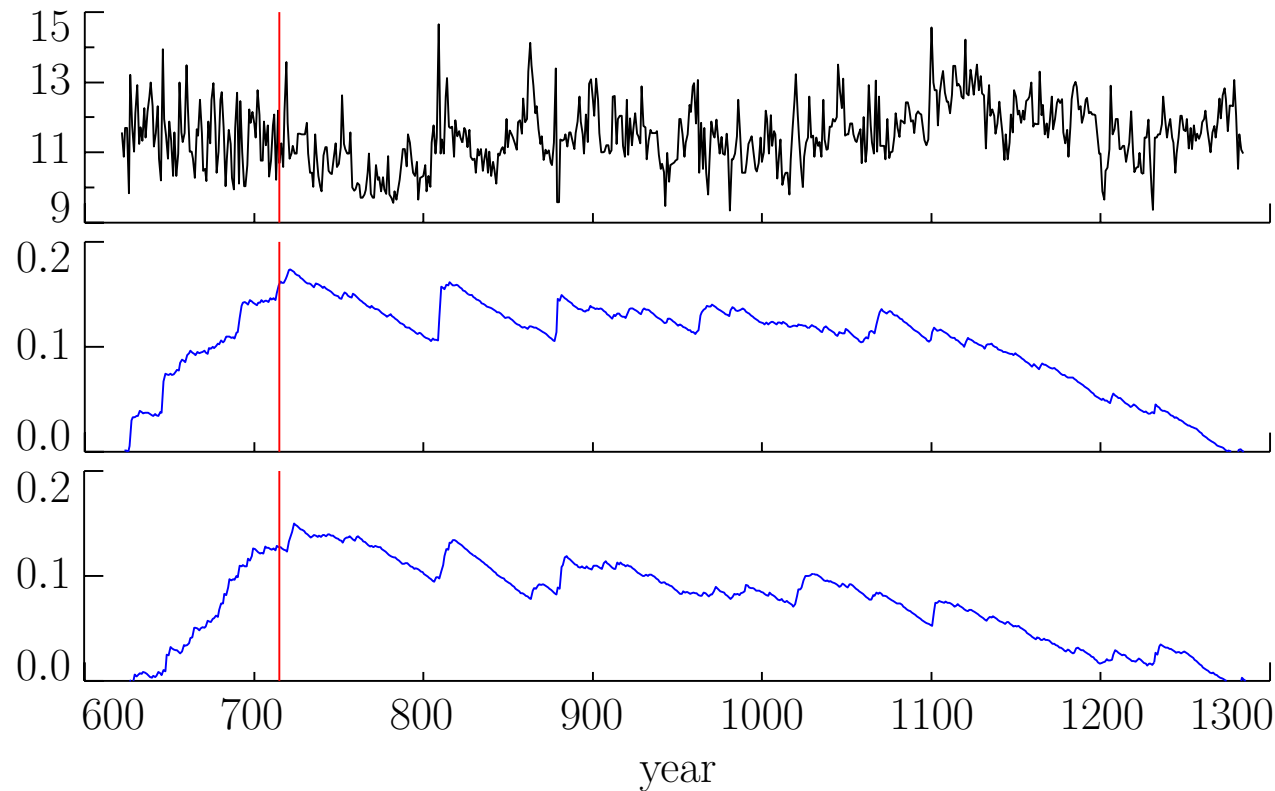
Example – Annual Minima of Nile River: IV

- results of testing all Nile River minima for homogeneity of variance using the Haar wavelet filter with critical values determined by computer simulations

τ_j	M'_j	D	critical levels		
			10%	5%	1%
1 year	331	0.1559	0.0945	0.1051	0.1262
2 years	165	0.1754	0.1320	0.1469	0.1765
4 years	82	0.1000	0.1855	0.2068	0.2474
8 years	41	0.2313	0.2572	0.2864	0.3436

- can reject null hypothesis of homogeneity of variance at level of significance 0.05 for scales τ_1 & τ_2 , but not at larger scales

Example – Annual Minima of Nile River: V



- Nile River minima (top plot) along with curves (constructed per Equation (382)) for scales τ_1 & τ_2 (middle & bottom) to identify change point via time of maximum deviation (vertical lines denote year 715)

Summary

- wavelets approximately decorrelate LMPs
- leads to practical and flexible schemes for simulating LMPs
- also leads to schemes for estimating parameters of LMPs
 - approximate maximum likelihood estimators (two varieties)
 - weighted least squares estimator
- can also devise wavelet-based tests for
 - homogeneity of variance
 - trends (see Section 9.4 & Craigmile *et al.*, *Environmetrics*, 15, 313–35, 2004, for details)